

# MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

100 V, 20 A, 24 m $\Omega$ 

## **FDMC86102**

### **General Description**

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

### **Features**

- Shielded Gate MOSFET Technology
- Max  $R_{DS(on)} = 24 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 7\text{A}$
- Max  $R_{DS(on)} = 38 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 5 \text{ A}$
- Low Profile 1 mm max in Power 33
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

### **Applications**

• DC-DC Conversion

### MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise specified)

| Symbol                               | Parameter   | Ratings        | Unit |
|--------------------------------------|---|----------------|------|
| $V_{DS}$                             | Drain to Source Voltage                             | 100            | V    |
| $V_{GS}$                             | Gate to Source Voltage                              | ±20            | V    |
| I <sub>D</sub>                       | Drain Current - Continuous T <sub>C</sub> = 25°C    | 20             | Α    |
|                                      | – Continuous T <sub>A</sub> = 25°C (Note 1a)        | 7              |      |
|                                      | - Pulsed (Note 4)                                   | 60             |      |
| E <sub>AS</sub>                      | Single Pulse Avalanche Energy (Note 3)              | 72             | mJ   |
| P <sub>D</sub>                       | Power Dissipation T <sub>C</sub> = 25°C             | 41             | W    |
|                                      | Power Dissipation T <sub>A</sub> = 25°C (Note 1a)   | 2.3            |      |
| T <sub>J</sub> ,<br>T <sub>STG</sub> | Operating and Storage Junction<br>Temperature Range | –55 to<br>+150 | °C   |

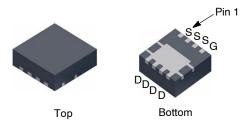
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL CHARACTERISTICS

| Symbol          | Parameter   | Value | Unit |
|-----------------|---|-------|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case              | 3     | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53    |      |

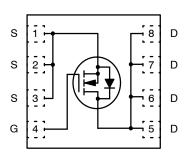
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| V <sub>DS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|-----------------|-------------------------|--------------------|
| 100 V           | 24 mΩ @ 10 V            | 20 A               |
|                 | 38 m $\Omega$ @ 6 V     |                    |



PQFN8 3.3 x 3.3, 0.65P CASE 483AK

### **PIN ASSIGNMENT**



**N-CHANNEL MOSFET** 

### MARKING DIAGRAM

ZXYYKK FDMC 86102

Z = Assembly Site Code
X = Year Code
YY = Weekly Code
KK = Lot Code
FDMC86102 = Specific Device Code

### **ORDERING INFORMATION**

| Device    | Package                            | Shipping <sup>†</sup> |
|-----------|------------------------------------|-----------------------|
| FDMC86102 | PQFN8<br>(Pb-Free,<br>Halide Free) | 3000 /<br>Tape & Reel |

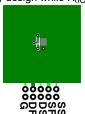
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

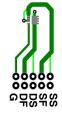
| Symbol                                   | Parameter   | Test Conditions   | Min | Тур      | Max  | Unit  |
|--|---|---|-----|----------|------|-------|
| OFF CHAR                                 | ACTERISTICS   |   |     |          |      |       |
| BV <sub>DSS</sub>                        | Drain to Source Breakdown Voltage                           | $I_D = 250 \mu A, V_{GS} = 0 V$   | 100 | -        | -    | V     |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$   | Breakdown Voltage Temperature<br>Coefficient                | I <sub>D</sub> = 250 μA, referenced to 25°C                                 | -   | 69       | -    | mV/°C |
| I <sub>DSS</sub>                         | Zero Gate Voltage Drain Current                             | V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V                               | -   | _        | 1    | μΑ    |
| I <sub>GSS</sub>                         | Gate to Source Leakage Current                              | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V                              | -   | <b>—</b> | ±100 | nA    |
| ON CHARA                                 | ACTERISTICS   |   |     |          |      |       |
| V <sub>GS(th)</sub>                      | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_D = 250 \mu A$  | 2.0 | 3.1      | 4.0  | V     |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$ | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D$ = 250 $\mu$ A, referenced to 25°C                                     | -   | -9       | _    | mV/°C |
| R <sub>DS(on)</sub>                      | Static Drain to Source On Resistance                        | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7 A                                | -   | 19.4     | 24   | mΩ    |
|  |   | V <sub>GS</sub> = 6 V, I <sub>D</sub> = 5 A                                 | -   | 26.8     | 38   | 1     |
|  |   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7 A, T <sub>J</sub> = 125°C        | -   | 32.8     | 41   | 1     |
| 9FS                                      | Forward Transconductance                                    | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7 A                                | -   | 19       | -    | S     |
| DYNAMIC                                  | CHARACTERISTICS   |   |     |          |      | •     |
| C <sub>iss</sub>                         | Input Capacitance   | V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz                    | -   | 725      | 965  | pF    |
| C <sub>oss</sub>                         | Output Capacitance  |   | -   | 175      | 235  | pF    |
| C <sub>rss</sub>                         | Reverse Transfer Capacitance                                | 1   | -   | 15       | 25   | pF    |
| R <sub>g</sub>                           | Gate Resistance   |   | -   | 0.5      | -    | Ω     |
| SWITCHIN                                 | G CHARACTERISTICS   |   |     |          |      |       |
| t <sub>d(on)</sub>                       | Turn-On Delay Time  | V <sub>DD</sub> = 50 V, I <sub>D</sub> = 7 A,                               | -   | 8        | 17   | ns    |
| t <sub>r</sub>                           | Rise Time   | $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$                                     | -   | 4        | 10   | 1     |
| t <sub>d(off)</sub>                      | Turn-Off Delay Time   |   | -   | 14       | 25   | 1     |
| t <sub>f</sub>                           | Fall Time   | 1   | -   | 4        | 10   |       |
| Q <sub>g(TOT)</sub>                      | Total Gate Charge   | V <sub>GS</sub> = 0 V to 10 V, V <sub>DD</sub> = 50 V, I <sub>D</sub> = 7 A | -   | 13       | 18   | nC    |
| Q <sub>g(TOT)</sub>                      | Total Gate Charge   | V <sub>GS</sub> = 0 V to 5 V, V <sub>DD</sub> = 50 V, I <sub>D</sub> = 7 A  | -   | 8        | 11   | 1     |
| Q <sub>gs</sub>                          | Total Gate Charge   | V <sub>DD</sub> = 50 V, I <sub>D</sub> = 7 A                                | -   | 3.7      | -    | nC    |
| Q <sub>gd</sub>                          | Gate to Drain "Miller" Charge                               | 1   | _   | 3.6      | -    | 1     |
| DRAIN-SO                                 | URCE DIODE CHARACTERISTICS                                  | •   | -   | -        | -    | -     |
| V <sub>SD</sub>                          | Source to Drain Diode Forward Voltage                       | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7 A (Note 2)                        | -   | 0.81     | 1.3  | V     |
|  |   | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2 A (Note 2)                        | _   | 0.75     | 1.2  | V     |
| t <sub>rr</sub>                          | Reverse Recovery Time                                       | I <sub>F</sub> = 7 A, di/dt = 100 A/μs                                      | _   | 44       | 70   | ns    |
|  |   | <del>-</del>  | -   |          | 65   | nC    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5  $\times$  1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 53°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%. 3. Starting  $T_J$  = 25°C; N-ch: L = 1 mH, I<sub>AS</sub> = 12 A, V<sub>DD</sub> = 90 V, V<sub>GS</sub> = 10 V. 4. Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

### TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

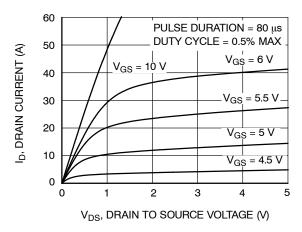


Figure 1. On-Region Characteristics

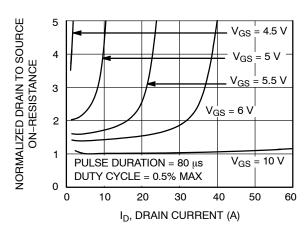


Figure 2. Normalized On–Resistance vs.

Drain Current and Gate Voltage

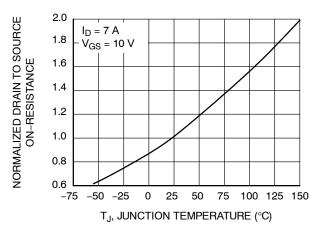


Figure 3. Normalized On Resistance vs.

Junction Temperature

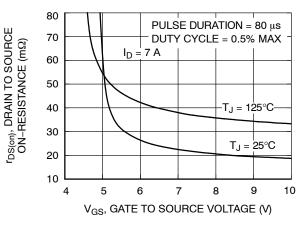


Figure 4. On-Resistance vs. Gate to Source Voltage

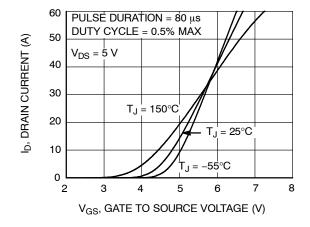


Figure 5. Transfer Characteristics

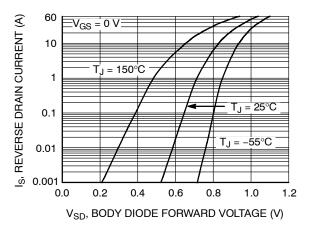


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

### TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

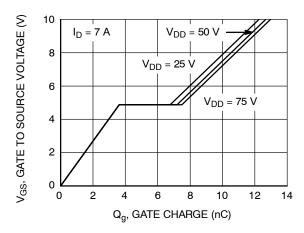


Figure 7. Gate Charge Characteristics

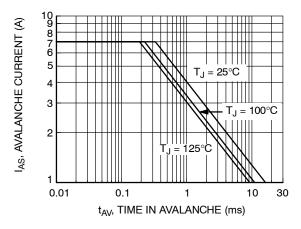


Figure 9. Unclamped Inductive Switching Capability

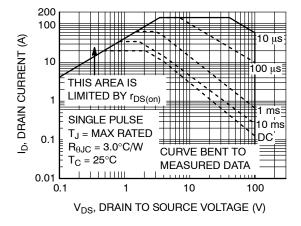


Figure 11. Forward Bias Safe Operating Area

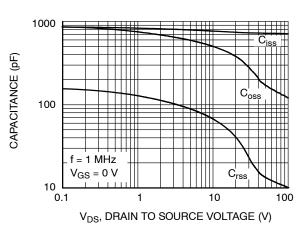


Figure 8. Capacitance vs. Drain to Source Voltage

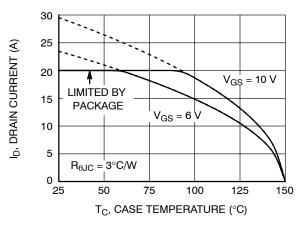


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

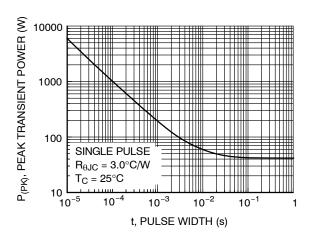


Figure 12. Single Pulse Maximum Power Dissipation

### TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$ 

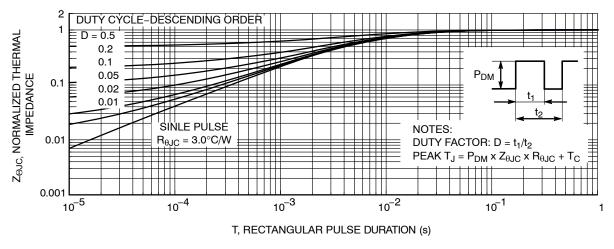


Figure 13. Transient Thermal Response Curve

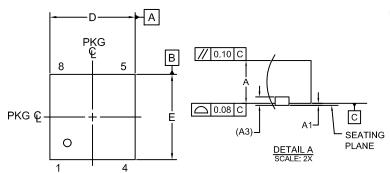
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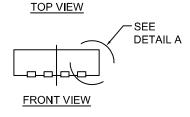
### PQFN8 3.3X3.3, 0.65P CASE 483AK **ISSUE B**

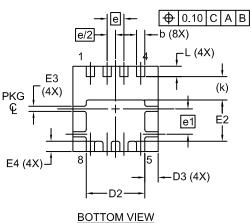
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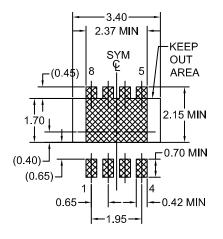


### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION. MILLIMETERS
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.







### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

| DIM | MILLIMETERS |      |      |  |
|-----|-------------|------|------|--|
| D   | MIN.        | NOM. | MAX. |  |
| Α   | 0.90        | 1.00 | 1.10 |  |
| A1  | 0.00        | -    | 0.05 |  |
| А3  | 0.20 REF    |      |      |  |
| b   | 0.27        | 0.32 | 0.37 |  |
| D   | 3.20        | 3.30 | 3.40 |  |
| D2  | 2.17        | 2.27 | 2.37 |  |
| D3  | 0.42        | 0.52 | 0.62 |  |
| E   | 3.20        | 3.30 | 3.40 |  |
| E2  | 1.50        | 1.60 | 1.70 |  |
| E3  | 0.10        | 0.20 | 0.30 |  |
| E4  | 0.29        | 0.39 | 0.49 |  |
| е   | 0.65 BSC    |      |      |  |
| e/2 | 0.325 BSC   |      |      |  |
| e1  | 0.98 BSC    |      |      |  |
| k   | 0.91 REF    |      |      |  |
| L   | 0.30        | 0.40 | 0.50 |  |
|     |             |      |      |  |

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| DESCRIPTION:     | PQFN8 3.3X3.3, 0.65P |   | PAGE 1 OF 1 |  |

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